Notice of References Cited Application/Control No. 10/519,407 Examiner Patricia L. Hailey Applicant(s)/Patent Under Reexamination NAITOU ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,458,740	10-2002	Kasuga et al.	502/211
*	В	US-2004/0073062	04-2004	Watanabe et al.	562/535
*	С	US-2004/0192973	09-2004	Liang et al.	568/470
*	D	US-2005/0137081	06-2005	Kauffman, James W.	502/311
*	Ε	US-5,126,307	06-1992	Yamamoto et al.	502/200
*	F	US-5,191,116	03-1993	Yamamatsu et al.	562/549
*	G	US-6,867,163	03-2005	Takezawa et al.	502/321
	Н	US-			131
	-	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N/	WO 2005/039760	05-2005	wo	Naitou et al.	B01J 27/199
	0					
	Р					
	Q					
	R					
	S					7
	۲					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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